

Search Notes

Application/Control No.

10/544,253

Examiner

HUYEN D. LE

Applicant(s)/Patent under
Reexamination

OHBAYASHI ET AL.

Art Unit

2615

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|------------------------------------|-----------|----------|
| 381 | 113, 116, 174, 175, 190, 191 | 9/14/2007 | HL |
| 381 | 369 | | HL |
| 367 | 170 | | HL |
| 367 | 181 | | HL |
| 367 | 140 | | HL |
| 310 | 322 | | HL |
| 310 | 334 | | HL |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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